

Course Name: Device Electronics for Integrated Circuits
Course Number: EE-311
Credits: 3-0-0-3
Semester: Odd
Prerequisites: IC121 (Mechanics of Particles and Waves)
Intended for: 2nd and 3rd year UG
Elective or Core: Core for 2nd Yr. and 3rd Yr. Electrical Engineering

Preamble:

The objective of the course is to provide the fundamental knowledge for understanding the concepts of semiconductor devices. This course build the knowledge base of the physics of semiconductors as related to the characteristics and design of solid-state electronic devices. This is a required core-course for Electrical Engineering undergraduate students.

COURSE SYLLABUS

- 1. SEMICONDUCTOR ELECTRONICS** **[6]**
 - i. Physics of Semiconductor Materials
 - ii. Band Model of Solids
 - iii. Carrier distribution functions
 - iv. Free Carriers in Semiconductors, Concept of electrons and holes,
 - v. Concept of equilibrium and non-equilibrium in semiconductor device
 - vi. Current Conduction mechanisms in semiconductors

- 2. P-N JUNCTIONS** **[12]**
 - i. Fundamentals of *p-n* junction
 - ii. *p-n* junction under thermal equilibrium
 - iii. Operation of *p-n* junction under forward and reverse bias
 - iv. Different type of junctions including step junction, linearly graded junction and heterojunctions,
 - v. Junction Breakdown: Physics of avalanche and Zener breakdown mechanisms
 - vi. Generation and Recombination in a *p-n* junction
 - vii. Current-Voltage Characteristics of p-n junctions
 - viii. Devices based on p-n junction, Solar cells, LED and photodetectors

- 3. METAL-SEMICONDUCTOR CONTACTS** **[3]**
 - i. Idealized Metal-Semiconductor junctions
 - ii. Physics of Schottky and Ohmic contacts
 - iii. Effect of surface states on Metal-Semiconductor Contacts,
 - iv. Devices based on metal-semiconductor contacts

- 4. BIPOLAR TRANSISTORS** **[9]**
 - i. Physics and operation of bipolar junction transistors

- ii. Current conduction mechanism in bipolar junction transistor
- iii. Ebers-Moll Model
- iv. Effects of Collector Bias Variation (Early Effect)
- v. Small-Signal Transistor Model
- vi. Operation of bipolar junction transistor under high frequency
- vii. Devices based on bipolar junction transistor

5. FIELD-EFFECT TRANSISTORS (MOSFETs) [9]

- i. The ideal MOS Structure
- ii. Capacitance of the MOS System
- iii. CV Behavior of a MOS System; Ideal condition, effect of oxide and interface charge
- iv. Structure and operation of MOSFET devices
- v. Improved Models for Short-Channel MOSFETs
- vi. Devices based on MOSFET

6. ELECTRONIC DEVICES AND NANOELECTRONICS [3]

- i. Electronic Device Materials: Silicon, Germanium, and Gallium Arsenide.
- ii. Introduction to advanced device technology: Purification and growth, wafer production, epitaxy and deposition, oxidation and metallisation; lithography and implantation
- iii. Emerging Device Technologies

TEXT BOOK:

SEMICONDUCTOR DEVICES- Physics and Technology, 3rd Edition, by S. M. Sze and M.K. Lee (John Wiley & Sons, 2012)

REFERENCES:

1. "Physics of Semiconductor Devices" by S. M. Sze and Kwok K.Ng, 3rd, Edition, (John Wiley & Sons, 2002)
2. "Solid State Electronic Devices", by Ben G. Steetman and Sanjay Banerjee 6th Edition, Prentice Hall, 2005
3. "Semiconductor Device Fundamentals", by Robert F. Pierret, Addison-Wesley Publishing, 1996
4. "Semiconductor Physics and Devices", by Donald A. Neamen, 3rd Eddition, McGrawHill, 2003
5. "Semiconductor Devices- Basic Principles", by Jasprit Singh, John Wiley and Sons Inc., 2001